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Application/Control No.

09/038,637 V1\knawn 10/809,983

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Hien N Nguyen Vn known

Applicant(s)/Patent Under Reexamination SWANSON ET AL.

Art Unit

2824 Unknown

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DATE: 9/4/04

E. Halakura)



**FORM PTO-1449** 

U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(USE SEVERAL SHEETS IF NECESSARY)

ATTY. DOCKET NO. APPLICATION NO. MICRON 215A -09/838,637-MICKON. 215 DUZCI UNKNOWY

**APPLICANT** Swanson et al.

**FILING DATE** August 14, 2000 2/13/03 **GROUP** 2818 UAKNOW 14

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BY APPLICANT	APPLICANT Swanson et al.	
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\*EXAMINER: INITIAL IF CITATION CONSIDERED, WHETHER OR NOT CITATION IS IN CONFORMANCE WITH MPEP 609; DRAW LINE THROUGH CITATION IF NOT IN CONFORMANCE AND NOT CONSIDERED, INCLUDE COPY OF THIS FORM WITH NEXT COMMUNICATION TO APPLICANT.